

# Search Notes



Application/Control No.

10/655,165

Examiner

JOHN PAK

Applicant(s)/Patent under Reexamination

WILLIAMS ET AL.

Art Unit

1616

## SEARCHED

Class	Subclass	Date	Examiner
514	549-552 558-560	1/06	} JP
504	100	↓	

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
STN online see printout	1/06	JP